

Notice of References Cited

Application/Control No.

10/521,572

Applicant(s)/Patent Under

Reexamination

ISHIKAWA ET AL.

Examiner

IAN JEN

Art Unit

3664

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0110649 A1	06-2003	Hudgens et al.	33/286
	B	US-			
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FOREIGN PATENT DOCUMENTS

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